

Notice of References Cited	Application/Control No. 10/516,786		Applicant(s)/Patent Under Reexamination EDELER ET AL.	
	Examiner KIET DOAN		Art Unit 2617	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,369,521	01-1983	Sawada, Takeshi	455/270
*	B	US-6,961,591	11-2005	Osano, Keiji	455/569.1
*	C	US-6,430,217	08-2002	Suzuki et al.	375/219
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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